

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/629,086	HAN ET AL.	
Examiner	Art Unit	
Tuvet Vo	2821	

Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
313	402,408	11/12/2005	τv		
315	85		1,		
362	246, 248	1	$\bigvee$		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
(313/402,408,407,238,477-479,313) combined with text such as electromagnetic wave shield/block/seal	11/12/2005	TV		
(315/85) combined with text search	11/12/2005	TV		
(362/248,246,236,227) combined with text search	11/12/2005	TV		